## (b) Amendments to the Claims

Kindly cancel claims 11 and 22 without prejudice or disclaimer of subject matter.

Please amend claims 9 and 12 as follows. A detailed listing of all the claims in the application is provided.

1. (Original) A bonding system comprising:

a processing unit which processes surfaces of first and second substrates;

an operation unit which overlays the first and second substrates processed by said processing unit; and

a chamber which accommodates and isolates from an outer space said processing unit and operation unit,

wherein a process for the first and second substrates by said processing unit includes a process of cleaning and/or activating the surfaces of the first and second substrates.

- 2. (Original) The system according to claim 1, further comprising a filter, wherein an interior of said chamber is cleaned by said filter.
- 3. (Original) The system according to claim 1, further comprising a loader connected to said chamber, said loader including a mechanism which purges an atmosphere in said chamber.

- 4. (Original) The system according to claim 1, further comprising a mechanism which increases a pressure in said chamber to be higher than that outside said chamber.
- 5. (Original) The system according to claim 1, wherein the process for the first and second substrates by said processing unit includes a process of removing a moisture on the surfaces of the first and second substrates to a predetermined level.
- 6. (Original) The system according to claim 1, wherein the process for the first and second substrates by said processing unit includes a process of removing a moisture on the surfaces of the first and second substrates to a predetermined level and thereafter setting the moisture on the surfaces to a predetermined level so that a bonding strength of the first and second substrates increases.
- 7. (Original) The system according to claim 1, wherein said processing unit comprises a mechanism which removes a particle on the surfaces of the first and second substrates.
- 8. (Original) The system according to claim 1, wherein said processing unit comprises a mechanism which removes an organic substance on the surfaces of the first and second substrates.
- 9. (Currently Amended) The system according to claim 1, wherein said processing unit comprises a mechanism which sets an activation state of the surfaces of the first and second substrate substrates to a predetermined state.

10. (Original) The system according to claim 9, wherein said processing unit comprises a mechanism which activates the surfaces of the first and second substrates so that a bonding strength of the first and second substrates increases.

## 11. (Cancelled)

12. (Currently Amended) A The bonding system according to claim 1, further comprising[[:]] a measurement unit in the chamber which measures a state of the surfaces of the first and second substrates[[;]] and wherein a the processing unit which processes the surfaces of the first and second substrates on the basis of a measurement result of said measurement unit[[;]]

an operation unit which overlays the first and second substrates processed by said processing unit; and

a chamber which accommodates said measurement unit, processing unit, and operation unit and isolates from an outer space,

wherein a process for the first and second substrates by said processing unit includes a process of cleaning the surfaces of the first and second substrates.

determination unit which checks whether or not the measurement result of said measurement unit is within a predetermined range, wherein the process by said processing unit is performed when said determination unit determines that the measurement result is not within the predetermined range.

- 14. (Original) The system according to claim 12, further comprising a filter, wherein an interior of said chamber is cleaned by said filter.
- 15. (Original) The system according to claim 12, further comprising a loader connected to said chamber, said loader including a mechanism which purges an atmosphere in said chamber.
- 16. (Original) The system according to claim 12, further comprising a mechanism which increases a pressure in said chamber to be higher than that outside said chamber.
- 17. (Original) The system according to claim 12, wherein said processing unit comprises a mechanism which removes a particle on the surfaces of the first and second substrates.
- 18. (Original) The system according to claim 12, wherein said processing unit comprises a mechanism which removes an organic substance on the surfaces of the first and second substrates.
- 19. (Original) The system according to claim 12, wherein said processing unit comprises a mechanism which activates the surfaces of the first and second substrates so that a bonding strength of the first and second substrates increases.

- 20. (Original) The system according to claim 12, wherein the process for the first and second substrates by said processing unit includes a process of setting a moisture on the surfaces of the first and second substrates to a predetermined level so that a bonding strength of the first and second substrates increases.
- 21. (Original) The system according to claim 12, further comprising a humidity maintaining unit which maintains a humidity in said chamber to a substantially constant level.
  - 22. (Cancelled)